

Description

The FDS4935BZ uses advanced trench technology and design to provide excellent R_{DS(ON)} with low gat e charge. It can be used in a wide variety of applications.

General Features

 $V_{DS} = -30V, I_{D} = -11A$

 $R_{DS(ON)}$ < 18m @ V $_{GS}$ =-10V

 $R_{DS(ON)}$ < 27m @ V GS=-4.5V

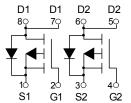
Application

PWM application

Load switch



SOP-8



Dual P-Channel MOSFET

Package Marking and Ordering Information

Product ID	Pack	Brand	Qty(PCS)
FDS4935BZ	SOP-8	HXY MOSFET	3000

Absolute Maximum Ratings (T_A=25[°]C unless otherwise noted)

Symbol	Parameter	Limit	Unit
V _{DS}	Drain-Source Voltage	-30	V
V _G s	Gate-Source Voltage	±20	V
l _D	Drain Current-Continuous	-11	Α
Ірм	Drain Current-Pulsed (Note 1)	-40	Α
Po	Maximum Power Dissipation	3.7	W
T _J ,T _{STG}	Operating Junction and Storage Temperature Range	-55 To 150	$^{\circ}$
Reja	Thermal Resistance,Junction-to-Ambient (Note 2)	33.8	°C/W



Electrical Characteristics (T_J=25°C unless otherwise specified)

Symbol	Parameter	Test Condition	Min.	Тур.	Max.	Units
$V_{(BR)DSS}$	Drain-Source Breakdown Voltage	V _{GS} =0V, I _D = -250μA	-30	-	-	V
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = -30V, V _{GS} =0V, -		-	-1	μΑ
Igss	Gate to Body Leakage Current	V _{DS} =0V, V _{GS} = ±20V	-	-	±100	nA
$V_{GS(th)}$	Gate Threshold Voltage	V _{DS} =V _{GS} , I _D = -250μA	-1.0	-1.6	-2.5	V
	Static Drain-Source on-Resistance	V _{GS} = -10V, I _D = -10A	-	14	18	0
$R_{DS(on)}$	Note3	V _{GS} = -4.5V, I _D = -5A	- 20 27		27	mΩ
C _{iss}	Input Capacitance	\/ - 45\/ \/ -0\/	-	1330	-	pF
Coss	Output Canacitance	V_{DS} = -15V, V_{GS} =0V, f =1.0MHz	-	183	-	pF
C _{rss}	Reverse Transfer Capacitance	I-1.UIVIIIZ	-	156	-	pF
Qg	Total Gate Charge	\/ 45\/ 5A	-	22	-	nC
Q _{gs}	Gate-Source Charge	V_{DS} = -15V, I_{D} = -5A, V_{GS} = -10V	-	1.0	-	nC
Q_{gd}	Gate-Drain("Miller") Charge	VGS10V	-	1.8	-	nC
t _{d(on)}	Turn-on Delay Time		-	9	-	ns
t _r	Turn-on Rise Time	V_{DD} = -15V, I_{D} = -10A, V_{GS} =-10V, R_{GEN} =2.5 Ω	-	13	-	ns
t _{d(off)}	Turn-off Delay Time		-	48	-	ns
t f	Turn-off Fall Time		-	20	-	ns
Is	Maximum Continuous Drain to Source	rce Diode Forward		-	-11	Α
	Current				40	•
I _{SM}	Maximum Pulsed Drain to Source Diod	e Forward Current	-	-	-40	Α
V_{SD}	Drain to Source Diode Forward	V _{GS} =0V, I _S = -15A	_	-0.8	-1.2	V
V 3D	Voltage	VG3 VV, 13 10/1		0.0		-
trr	Reverse Recovery Time	TJ=25℃,	-	64	-	ns
Qrr		V_{DD} = -24V, I_F =-2.8A, dI/dt=-100A/ μ s	-	25	-	nC

Notes:1. Repetitive Rating: Pulse Width Limited by Maximum Junction Temperature

- 2. EAS condition: $T_J = 25\,^{\circ}\!\!\mathrm{C}$, $V_{GS} = 10V$, $R_G = 25\Omega$, L=0.5mH, $I_{AS} = -12.7A$
- 3. Pulse Test: Pulse Width≤300µs, Duty Cycle≤0.5%



Typical Performance Characteristics

Figure1: Output Characteristics

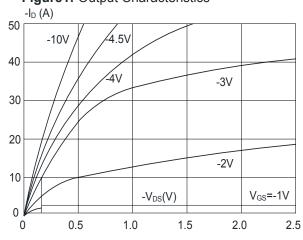


Figure 2: Typical Transfer Characteristics

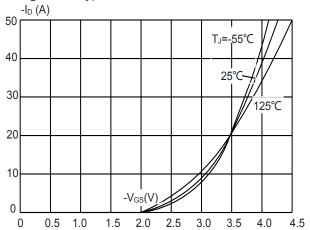


Figure 3:On-resistance vs. Drain Current

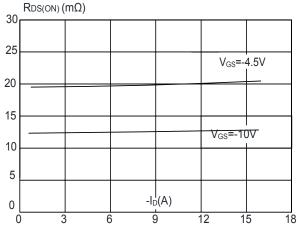


Figure 4: Body Diode Characteristics

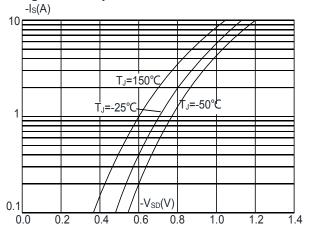


Figure 5: Gate Charge Characteristics

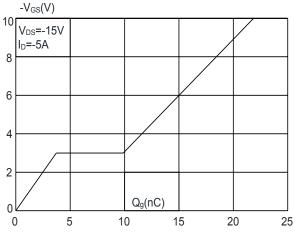


Figure 6: Capacitance Characteristics

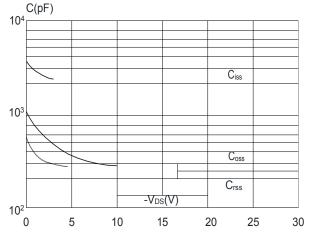




Figure 7: Normalized Breakdown Voltage vs. Junction Temperature

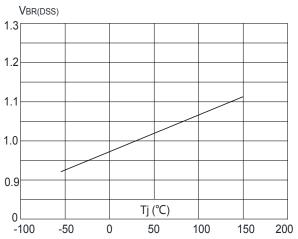


Figure 9: Maximum Safe Operating Area

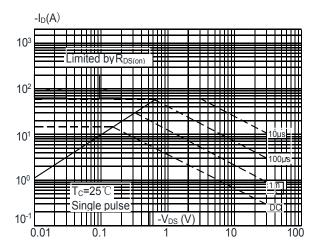


Figure.11: Maximum Effective Transient Thermal Impedance, Junction-to-Case

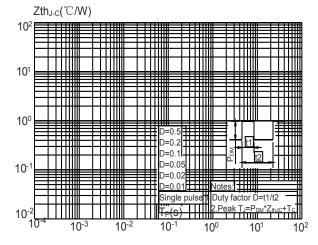


Figure 8: Normalized on Resistance vs. Junction Temperature

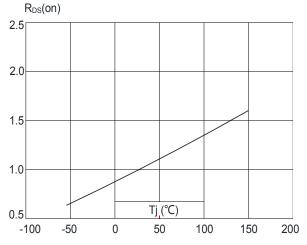
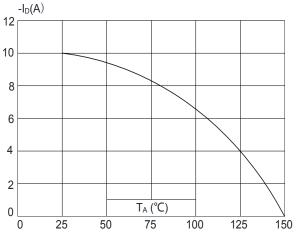


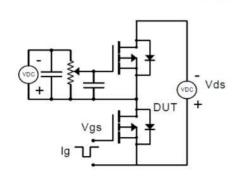
Figure 10: Maximum Continuous Drain Current vs. Ambient Temperature

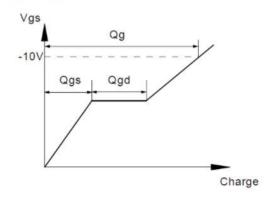




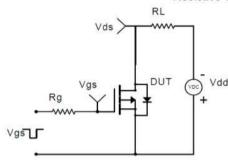
Test Circuit

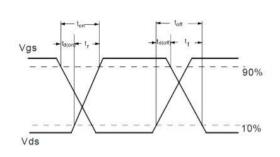
Gate Charge Test Circuit & Waveform



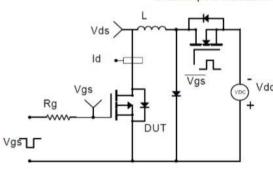


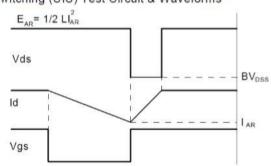
Resistive Switching Test Circuit & Waveforms



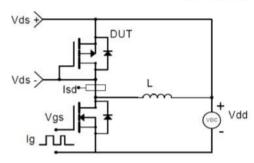


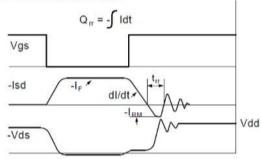
Unclamped Inductive Switching (UIS) Test Circuit & Waveforms





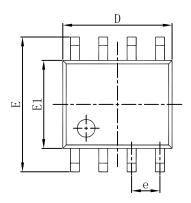
Diode Recovery Test Circuit & Waveforms

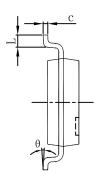


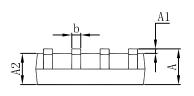




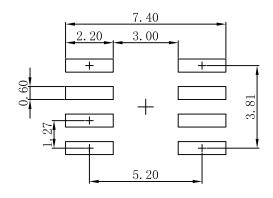
SOP-8 Package Outline Dimensions







Symbol	Dimensions In Millimeters		Dimensions In Inches	
3y111001	Min	Max	Min	Max
A	1.350	1.750	0.053	0.069
A1	0. 100	0. 250	0.004	0.010
A2	1. 350	1. 550	0.053	0.061
b	0.330	0.510	0.013	0.020
c	0. 170	0. 250	0.007	0.010
D	4.800	5. 000	0. 189	0. 197
e	1.270 (BSC)		0.050 (BSC)	
E	5. 800	6. 200	0. 228	0. 244
E1	3.800	4. 000	0. 150	0. 157
L	0.400	1. 270	0.016	0.050
θ	0°	8°	0°	8°



- Note: 1.Controlling dimension: in millimeters.
- 2.General tolerance:± 0.05mm.
 3.The pad layout is for reference purposes only.



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